









## Richard Attrill – June 2017 (Rev 1)



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## **Introduction**

Whilst working with controlled impedance designs it is often desirable to compare the reality of the measurement data against the modelled structure.

'Closing the loop' between the predicted and actual measured results has a number of benefits for both the design and fabrication environments. It allows for fine tuning of the structure parameters in future manufacturing batches, statistical analysis and improved overall process control.

This new capability will be introduced into Polar's Si8000m / Si9000e field solver products allowing the user to quickly import measurement data directly from the industry-standard Controlled Impedance Test System (CITS).

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-Step 2 : Select Data	a Log Record	Each test record type found in the data
Data Log Records	Description - L01, Layer - 1, Nominal Impedance - 60.00	log file is listed in the drop down. In this
Project Structure	Description - L01, Layer - 1, Nominal Impedance - 60.00	Case there are four tests.
Description	Description - L03, Layer - 3, Nominal Impedance - 60.00 Description - L06, Layer - 6, Nominal Impedance - 60.00 Description - L08, Layer - 8, Nominal Impedance - 60.00	
Nominal Impedance	60.00 Tol+ % 10.00 Tol- % 10.00	Polar Si9000 PCB
		File Edit Configu
Step 2 : Select Data	a Log Record	
Data Log Records	Description - L01, Layer - 1, Nominal Impedance - 60.00	
Project Structure	L1 60 ohms (1)	
Description	L1 60 ohms (1) L3 50 ohms (2)	
Nominal Impedance	LS 60 ohms (2) L6 60 ohms (3) L8 60 ohms (4)	
match a one of the f	our modelled	L3 60 ohms (2)
uctures from the Proj	ecord simply	
lect the structure from	n the Project	
ructure dropdown		
		L6 60 ohms (3)
		the Project group

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Measurement Data:

The CITS Data Log data may also be viewed in a data grid layout. This is especially useful for viewing the Result data (Pass / Fail)

					$\searrow$	\ \													
Graph	Analusis	(1) Analusis (2)	Me	easurement [	Data														
anapril	- maiyore	(()  · · · · · · · · · · · · · · · · · · ·																	
Result	Index	Board Serial		Date	Time	Average	SD	Maximum	Minimum	Station	Description	Layer		Nominal	Tol+ %	Tol- %	_	Instrument	Serial No
Pass	1		24	05/02/13	12:48	60.8	0.8	61.9	59.56	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Pass	2	2 :	29	05/02/13	12:50	61.77	0.95	63.21	59.93	_TEST STATION 1_	L01		1	60	11	D	10	CITS880	1758
Pass	3	3	17	05/02/13	12:51	63.01	0.94	64.48	61.68	_TEST STATION 1_	L01		1	60	11	D	10	CITS880	1758
Pass	4	4	39	05/02/13	12:52	63.22	1.07	64.62	61.29	_TEST STATION 1_	L01		1	60	11	D	10	CITS880	1758
Pass	5	5	8	05/02/13	12:59	63.93	0.95	65.32	62.2	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Pass	6	3	10	05/02/13	13:00	61.17	0.89	62.69	59.63	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Pass	7	7	32	05/02/13	13:01	62.38	0.88	63.58	60.72	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Pass	8	3	21	05/02/13	13:01	62.37	0.82	63.88	60.98	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Pass	9	9	4	05/02/13	13:02	63.35	0.68	64.41	61.75	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Pass	10	) :	33	05/02/13	13:03	61.81	0.78	62.95	60.09	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Pass	11	•	18	05/02/13	13:03	60.22	0.62	61.48	59.09	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Pass	12	2	3	05/02/13	13:04	60.54	0.75	62.1	59.19	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Pass	13	3	15	05/02/13	13:05	61.46	0.73	62.83	60.12	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Pass	14	1	2	05/02/13	13:05	60.09	0.67	61.24	58.57	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Pass	15	5 3	23	05/02/13	13:06	61.01	0.78	62.4	59.69	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Pass	16	6	5	05/02/13	13:07	61.05	0.63	62.14	59.49	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Pass	17	7	6	05/02/13	13:07	61.54	0.8	62.98	60.11	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Pass	18	3	76	05/02/13	13:08	62.49	0.92	63.44	60.32	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Pass	19	9	11	05/02/13	13:09	61.79	0.83	63.08	60.37	_TEST STATION 1_	L01		1	60	1	D	10	CITS880	1758
Page	20	1 .	21	05/02/13	12.09	60.25	0.65	E1 37	59.95	TEST STATION 1	1.01		1	03	1	n	10	0882710	1759



Thank you for viewing this preview presentation.

This release is scheduled for early Q3 2017 and will be included as part of a Polarcare maintenance release for existing customers.

If you would like to have a web-based demonstration please contact your local Polar office, details are shown on the last slide of this presentation.















# Thank you



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Coated Microstrip 1B	Edge-Coupled Offset Stripline 1B1A1R	Surface Coplanar Strips With Ground 2B	Coated Coplanar Strips 2B	Diff Coated Coplanar Waveguide 2B	Dual Coated Microstrip 1B	Edge-Coupled Offset Stripline 2B1
						HG E0 HG E2 HG E2 HG E7 HG WY
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